


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/709,952	BISHOP ET AL.	
	Examiner	Art Unit	
	Matthew Heneghan	2134	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
IEEE, ACM Searches, see notes	7/8/2007	MH
EAST, keyword+class searches, see notes	7/8/2007	MH
Inventor Search	7/8/2007	MH